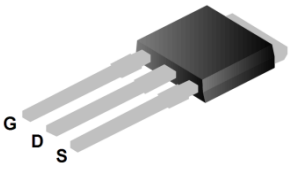
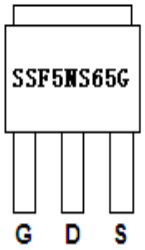
Main Product Characteristics:

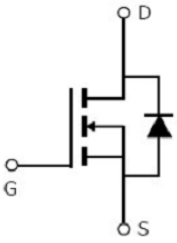
V_{DSS}	650V
R_{DS}(on)	1.0Ω (typ.)
I_D	5A ①



TO-251



Marking and pin Assignment



Schematic diagram

Features and Benefits:

Feathers:

- High dv/dt and avalanche capabilities
- 100% avalanche tested
- Low input capacitance and gate charge
- Low gate input resistance

Description:

The SSF5NS65G series MOSFETs is a new technology, which combines an innovative super junction technology and advance process. This new technology achieves low Rdson, energy saving, high reliability and uniformity, superior power density and space saving.

Absolute max Rating:

Symbol	Parameter	Max.	Units
I_D @ TC = 25°C	Continuous Drain Current, V_{GS} @ 10V	5 ①	A
I_D @ TC = 100°C	Continuous Drain Current, V_{GS} @ 10V	3.1①	
I_{DM}	Pulsed Drain Current ②	15	
P_D @TC = 25°C	Power Dissipation ③	50	W
	Linear Derating Factor	0.4	W/°C
V_{DS}	Drain-Source Voltage	650	V
V_{GS}	Gate-to-Source Voltage	± 30	V
E_{AS}	Single Pulse Avalanche Energy @ L=22.4mH	54	mJ
I_{AR}	Avalanche Current @ L=22.4mH	2.2	A
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +150	°C

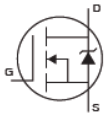
Thermal Resistance

Symbol	Characterizes	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-case ③	—	2.5	℃/W
$R_{\theta JA}$	Junction-to-ambient (t ≤ 10s) ④	—	75	℃/W

Electrical Characterizes @T_A=25℃ unless otherwise specified

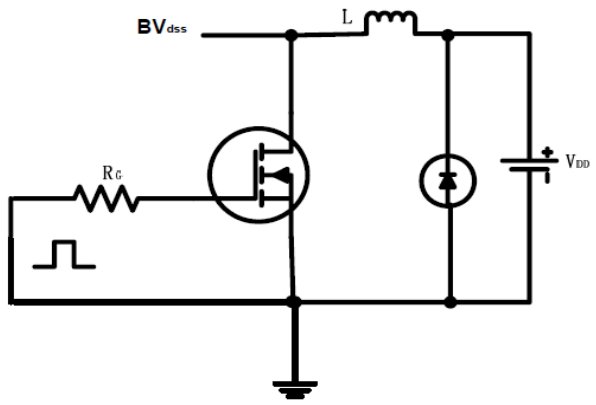
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	650	—	—	V	V_{GS} = 0V, I_D = 250μA
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	1.0	1.2	Ω	V_{GS}=10V,I_D = 1A
		—	2.2	—		T_J = 125°C
$V_{GS(th)}$	Gate threshold voltage	2	—	4	V	V_{DS} = V_{GS}, I_D = 250μA
		—	2.7	—		T_J = 125°C
I_{DSS}	Drain-to-Source leakage current	—	—	1	μA	V_{DS} = 650V,V_{GS} = 0V
		—	—	50		T_J = 125°C
I_{GSS}	Gate-to-Source forward leakage	—	—	100	nA	V_{GS} =30V
		—	—	-100		V_{GS} = -30V
Q_g	Total gate charge	—	8.3	—	nC	I_D = 4A,
Q_{gs}	Gate-to-Source charge	—	2.3	—		V_{DS}=100V,
Q_{gd}	Gate-to-Drain("Miller") charge	—	2.6	—		V_{GS} = 10V
$t_{d(on)}$	Turn-on delay time	—	9.9	—	ns	V_{GS}=10V, V_{DS} =380V, R_{GEN}=18Ω,I_D =4.5A
t_r	Rise time	—	18.4	—		
$t_{d(off)}$	Turn-Off delay time	—	18.1	—		
t_f	Fall time	—	15.3	—		
C_{iss}	Input capacitance	—	267	—	pF	V_{GS} = 0V
C_{oss}	Output capacitance	—	220	—		V_{DS} = 25V
C_{rss}	Reverse transfer capacitance	—	4.76	—		f = 1MHz

Source-Drain Ratings and Characteristics

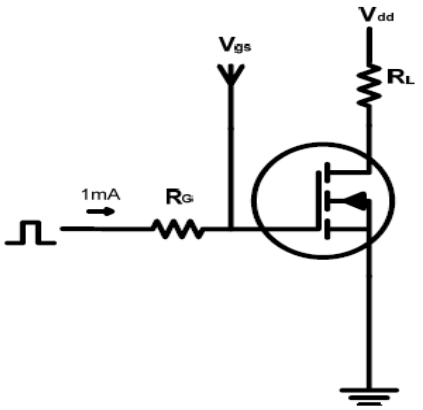
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	5 ①	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode)	—	—	15	A	
V_{sd}	Diode Forward Voltage	—	0.85	1.2	V	I_S=2.8A, V_{GS}=0V
t_{rr}	Reverse Recovery Time	—	284	—	nS	T_J = 25°C, I_F = I_S, di/dt = 100A/μs
Q_{rr}	Reverse Recovery Charge	—	1395	—	nC	

Test circuits and Waveforms

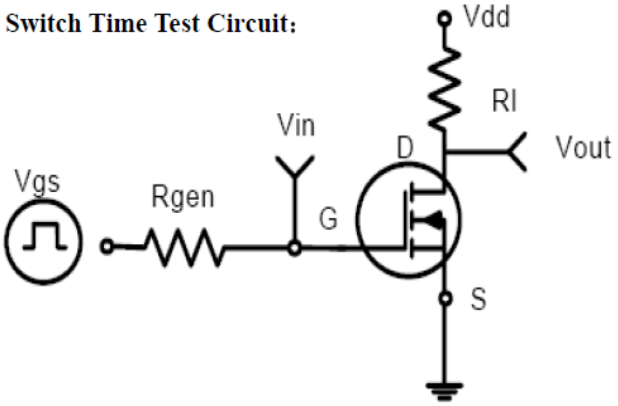
EAS test circuits:



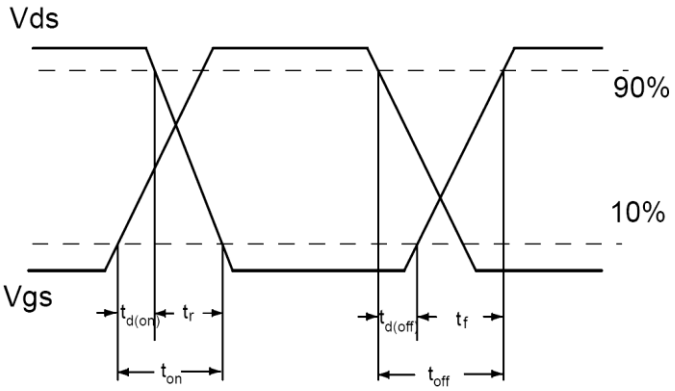
Gate charge test circuit:



Switch Time Test Circuit:



Switch Waveforms:



Notes:

①Calculated continuous current based on maximum allowable junction temperature.

②Repetitive rating; pulse width limited by max. junction temperature.

③The power dissipation PD is based on max. junction temperature, using junction-to-case thermal resistance.

④The value of $R_{\theta JA}$ is measured with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with TA =25°C

Typical electrical and thermal characteristics

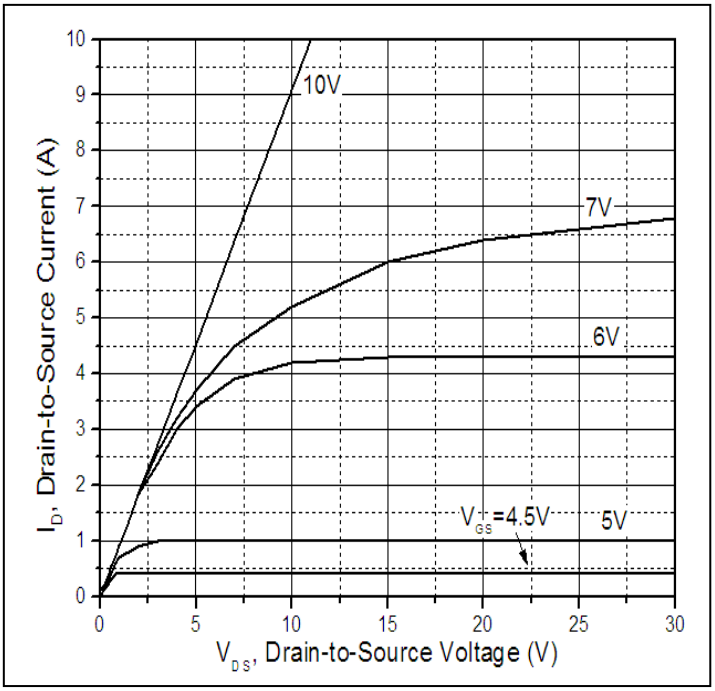


Figure 1: Typical Output Characteristics

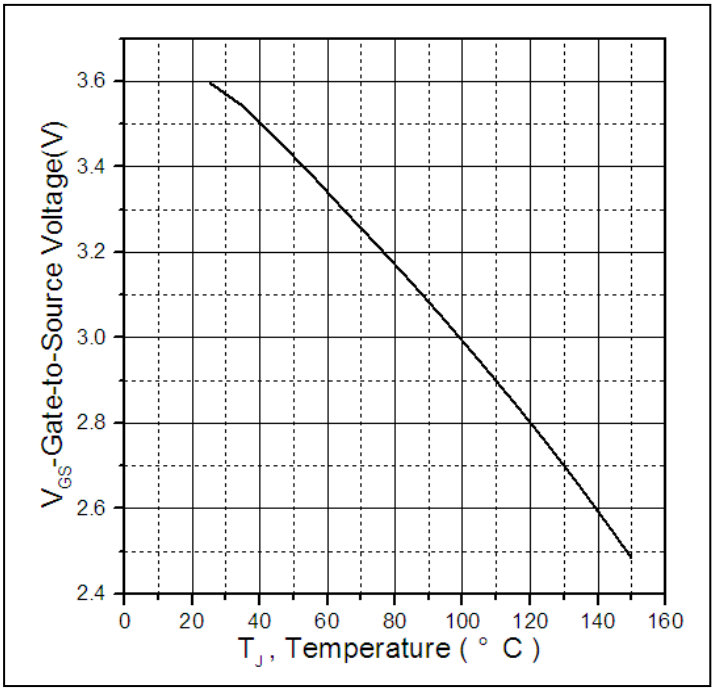


Figure 2. Gate to source cut-off voltage

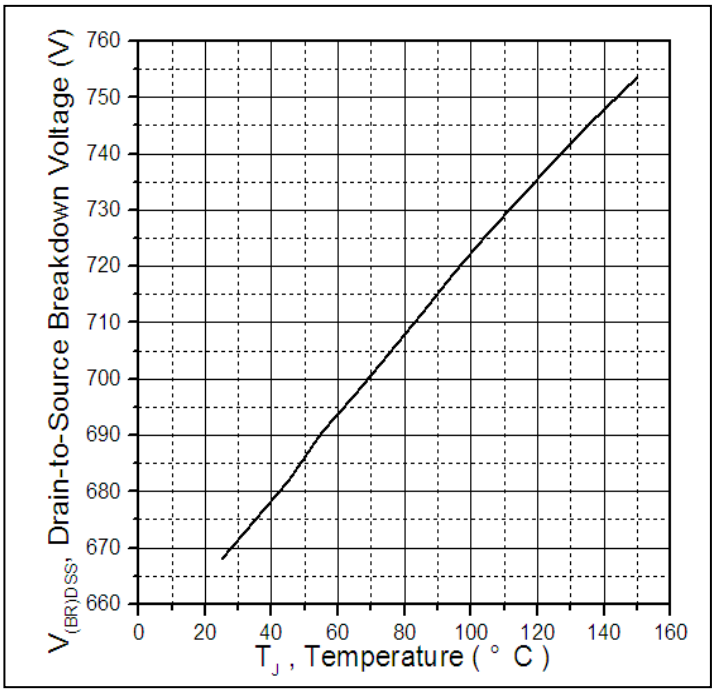


Figure 3. Drain-to-Source Breakdown Voltage Vs. Case Temperature

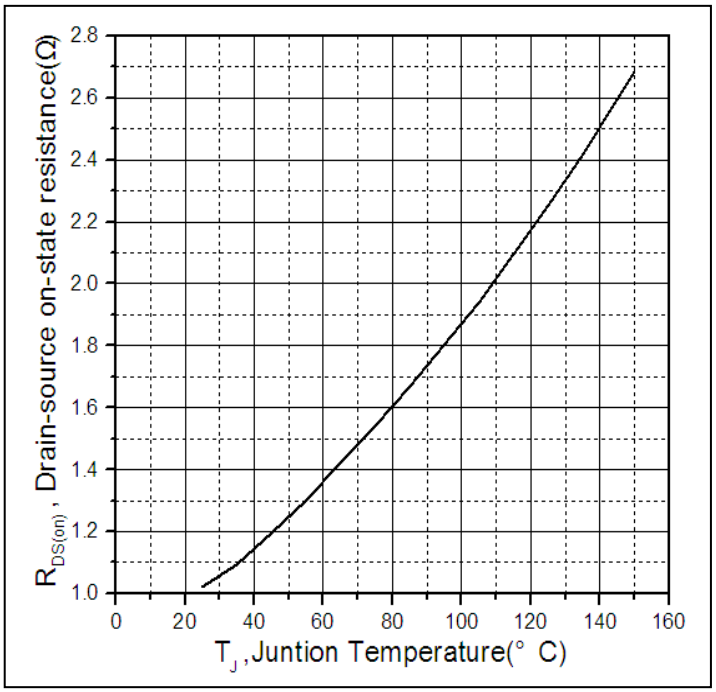


Figure 4: Normalized On-Resistance Vs. Case Temperature

Typical electrical and thermal characteristics

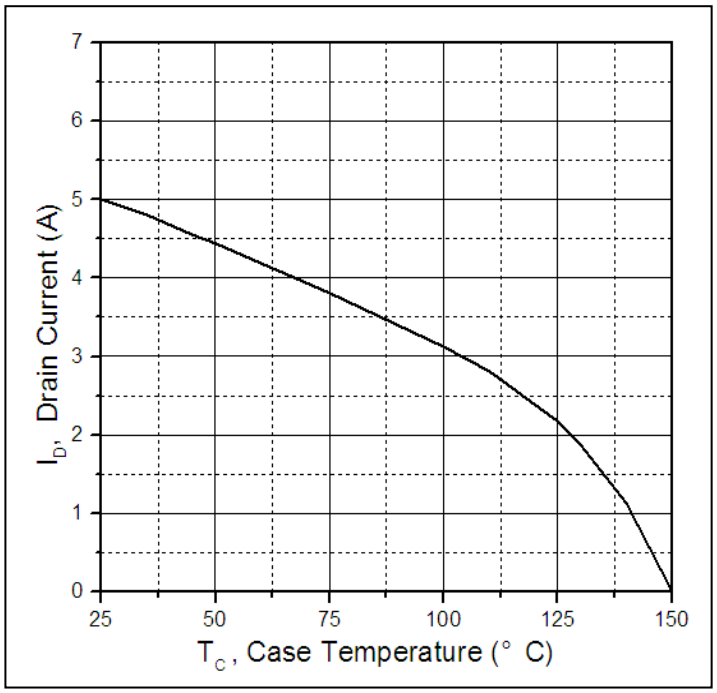


Figure 5. Maximum Drain Current Vs. Case Temperature

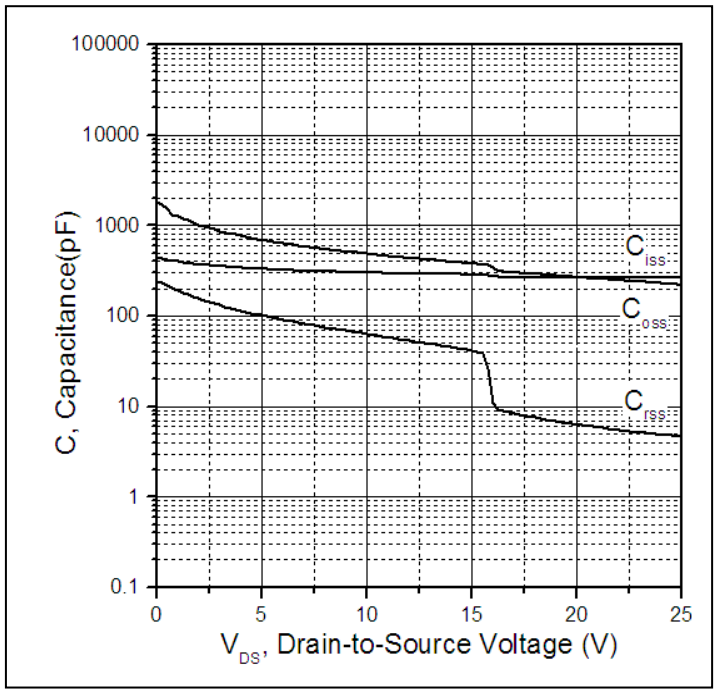


Figure 6. Typical Capacitance Vs. Drain-to-Source Voltage

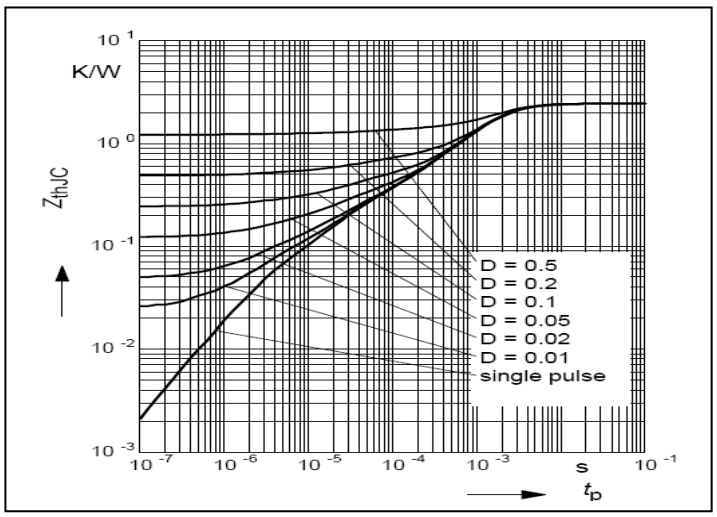
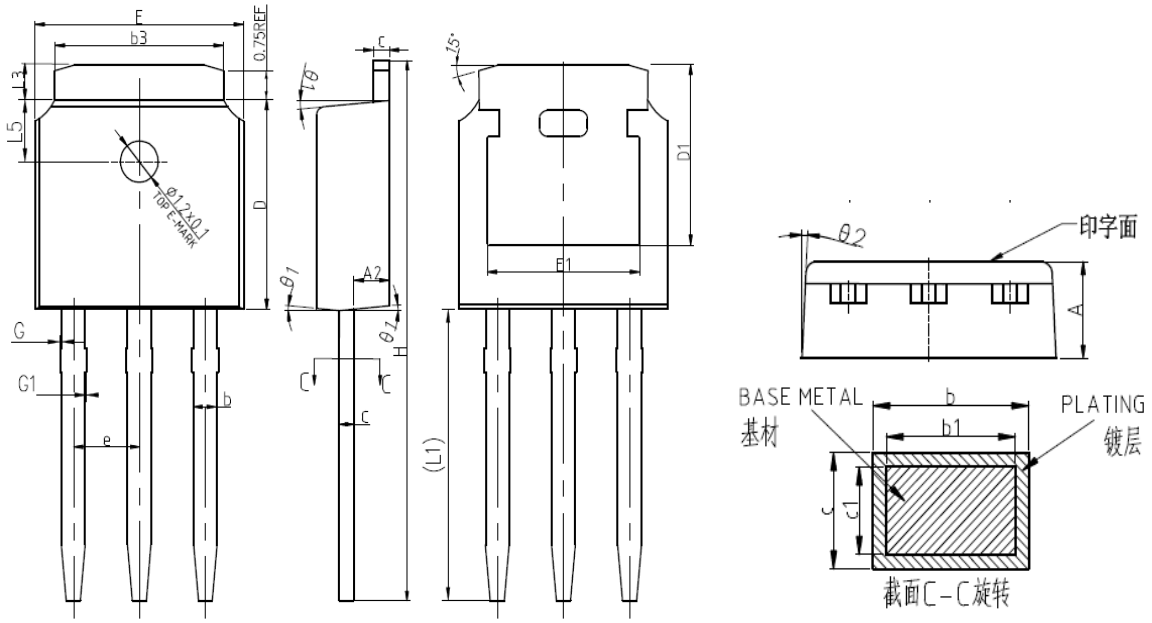


Figure7. Maximum Effective Transient Thermal Impedance Junction-to-Case

Mechanical Data：

TO-251 PACKAGE OUTLINE DIMENSION



Symbol	Dimension In Millimeters			Dimension In Inches		
	Min	Nom	Max	Min	Nom	Max
A	2.200	2.300	2.380	0.087	0.091	0.094
A2	0.970	1.070	1.170	0.038	0.042	0.046
b	0.720	0.780	0.850	0.028	0.031	0.033
b1	0.710	0.760	0.810	0.028	0.030	0.032
b3	5.230	5.330	5.460	0.206	0.210	0.215
c	0.470	0.530	0.580	0.019	0.021	0.023
c1	0.460	0.510	0.560	0.018	0.020	0.022
D	6.000	6.100	6.200	0.236	0.240	0.244
D1		5.300REF			0.209REF	
E	6.500	6.600	6.700	0.256	0.260	0.264
E1	4.700	4.830	4.920	0.185	0.190	0.194
e		2.286BSC			0.090BSC	
H	16.100	16.400	16.600	0.634	0.646	0.654
L1	9.200	9.400	9.600	0.362	0.370	0.378
L3	0.900	1.020	1.250	0.035	0.040	0.049
L5	1.700	1.800	1.900	0.067	0.071	0.075
θ1	5°	7°	9°	5°	7°	9°
θ2	5°	7°	9°	5°	7°	9°
G	0.000		0.076	0.000	0.000	0.003
G1	0.000		0.076	0.000	0.000	0.003

Ordering and Marking Information

Device Marking: SSF5NS65G

Package (Available)

TO-251(IPAK)

Operating Temperature Range

C : -55 to 150 ºC

Devices per Unit

Package Type	Units/ Tube	Tubes/Inner Box	Units/Inner Box	Inner Boxes/Carton Box	Units/Carton Box
TO-251	80	60	4800	5	24000

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	T_j=125℃ to 150℃ @ 80% of Max V_{DSS}/V_{CES}/VR	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	T_j=150℃ @ 100% of Max V_{GSS}	168 hours 500 hours 1000 hours	3 lots x 77 devices

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